

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination QADEER ET AL.	
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U.S. PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Tyrrell et al. "CSP Methods for Identifying Atomic Actions in the Design of Fault Tolerant Concurrent Systems" IEEE 1995
*	V	Reps et al. "Precise Interprocedural Dataflow Analysis via Graph Reachability", 1995 ACM.
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